



NOTES:

1. OPERATION WAVELENGTH: 200 nm–2.1 μ m
2. CLEAR APERTURE (S1,S2,S3) : >70%CA
3. ANGLE TOLERANCE: <3 arcmin
4. SURFACE QUALITY (S1,S2,S3) : 40/20 (S/D)
5. SURFACE FLATNESS (S1,S2,S3) : $\lambda/10@632.8$ nm
6. CHAMFER: <0.2 mm, 45°
7. COATING (S1,S2,S3) : UNCOATED
8. OTHER SURFACES: FINE GROUND

DRAWING PROJECTION			LBTEK			
	NAME	DATE	RAP215			
DRAWN	LZHOU	MAR./15th/24	RIGHT ANGLE PRISM L x H=15.0 mm x 15.0 mm, UNCOATED			
APPROVAL	WCHENG	MAR./15th/24	MATERIAL	WEIGHT	SCALE	REV
FOR INFORMATION ONLY NOT FOR MANUFACTURING PURPOSES			UVFS	3.71 g	4:1	B